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URL: <http://www.SanDiegoHTPD2018.com>

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Research Lines: [Computational Modeling for Fusion](#)

Publication: 22nd Topical Conference on High Temperature Plasma Diagnostics (HTPD 2018)

Barcelona Supercomputing Center - Centro Nacional de Supercomputación

Source URL (retrieved on 23 abr 2024 - 19:07): <https://www.bsc.es/ca/research-and-development/publications/analysis-metalic-impurity-content-means-vuv-and-sxr>